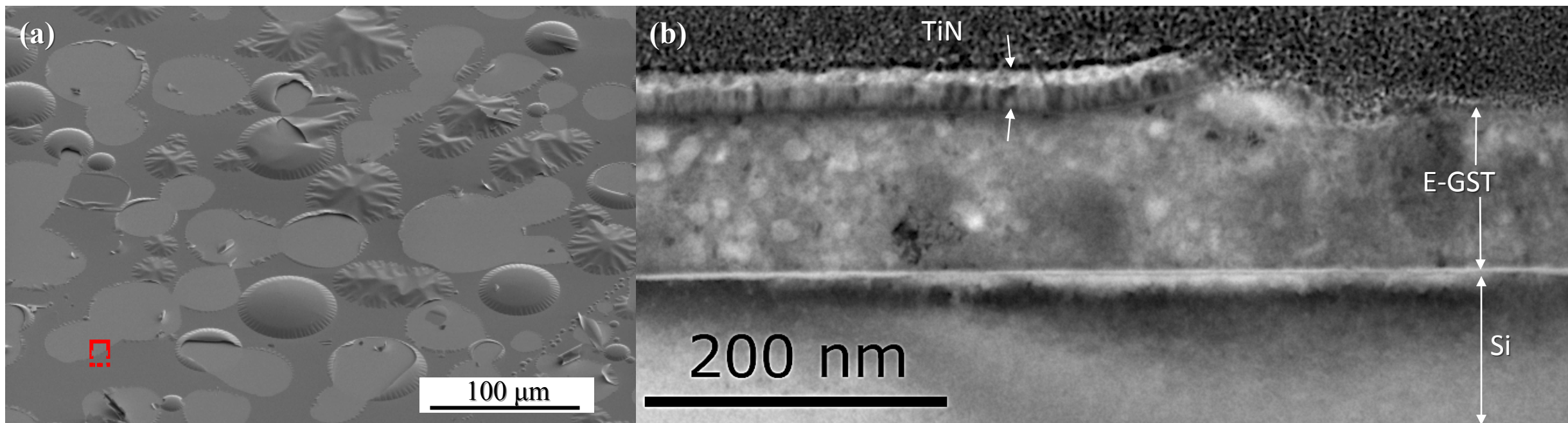


Supporting info



S1. (a) SEM image of the surface of E-GST annealed at 450°C for 30 minutes. (b) BT-TEM on FIB lamella cut in correspondence of a blister's edge, as shown by the red square in (a).